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AO3416 20V N-Channel MOSFET

General Description

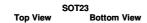
The AO3416 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 1.8V. This device is suitable for use as a load switch or in PWM applications. It is ESD protected.

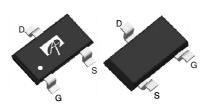
Product Summary

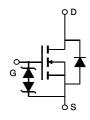
 $\begin{array}{lll} V_{DS} & 20V \\ I_{D} \; (at \; V_{GS} \! = \! 4.5V) & 6.5A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 22m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} = 2.5V) & < 26m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} = 1.8V) & < 34m\Omega \end{array}$

ESD protected









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Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	20	V	
Gate-Source Voltage		V _{GS}	±8	V	
Continuous Drain	T _A =25℃		6.5		
Current	T _A =70℃	'D	5.2	Α	
Pulsed Drain Current ^c		I _{DM}	30		
	T _A =25℃	В	1.4	W	
Power Dissipation ^B	T _A =70℃	$-P_{D}$	0.9	VV	
Junction and Storage Temperature Range T		T _J , T _{STG}	-55 to 150	C	

Thermal Characteristics								
Parameter		Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient ^A	t ≤ 10s	В	70	90	℃/W			
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	100	125	℃/W			
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	63	80	℃/W			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units			
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	20			V			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =20V, V _{GS} =0V			1	μA			
	-	T _J =55℃			5	·			
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±8V			±10	μΑ			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	0.4	0.7	1.1	V			
$I_{D(ON)}$	On state drain current	V_{GS} =4.5V, V_{DS} =5V	30			Α			
		V_{GS} =4.5V, I_{D} =6.5A		16	22	mΩ			
R _{DS(ON)}	Static Drain-Source On-Resistance	T _J =125℃		22	30				
20(014)		V_{GS} =2.5V, I_{D} =5.5A		18	26	mΩ			
		$V_{GS}=1.8V$, $I_D=5A$		21	34	mΩ			
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=6.5A$		50		S			
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.62	1	V			
I _S	Maximum Body-Diode Continuous Curr			2	Α				
DYNAMIC	PARAMETERS								
C_{iss}	Input Capacitance			1295	1650	pF			
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =10V, f=1MHz		160		pF			
C_{rss}	Reverse Transfer Capacitance			87		pF			
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz		1.8		KΩ			
SWITCHI	NG PARAMETERS								
Q_g	Total Gate Charge			10		nC			
Q_{gs}	Gate Source Charge	V_{GS} =4.5V, V_{DS} =10V, I_{D} =6.5A		4.2		nC			
Q_{gd}	Gate Drain Charge	1		2.6		nC			
t _{D(on)}	Turn-On DelayTime			280		ns			
t _r	Turn-On Rise Time	V_{GS} =4.5V, V_{DS} =10V, R_{L} =1.54 Ω ,		328		ns			
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}=3\Omega$		3.76		us			
t _f	Turn-Off Fall Time			2.24		us			
t _{rr}	Body Diode Reverse Recovery Time	I _F =6.5A, dI/dt=100A/μs		31	41	ns			
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =6.5A, dI/dt=100A/μs		6.8		nC			

A. The value of $R_{\theta JA}$ is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design. B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using \leqslant 10s junction-to-ambient thermal resistance.

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C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initialT_{.i}=25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

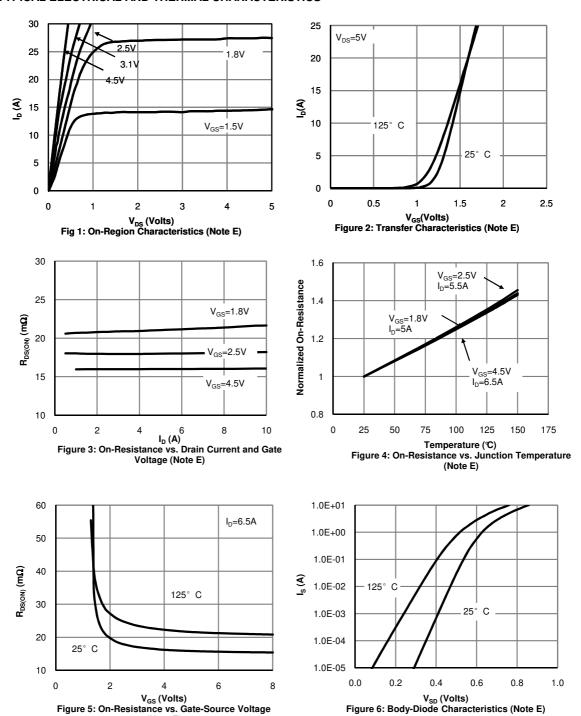
E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J_j(MAX)}=150^\circ$ C. The SOA curve provides a single pulse rating.

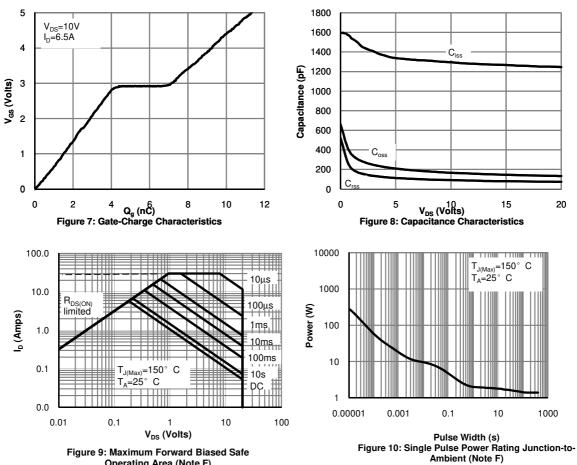


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

(Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Operating Area (Note F)

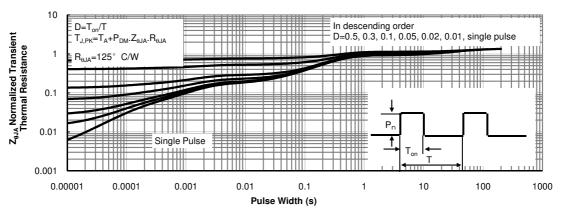
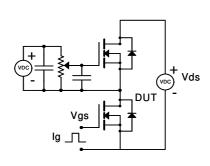
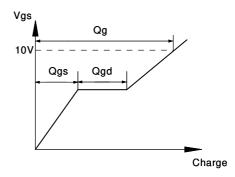


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

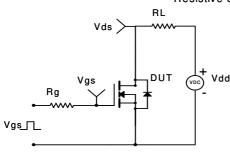


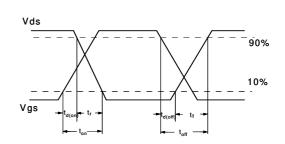
Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

